



NASA EXPLORES

**Heavy Ion Single-Event Effects (SEE) Test Facility Status
and General Implications for Space System Evolution**

Jonny Pellish, NASA Electronic Parts Manager

June 2021



Outline

Origins – why do we need SEE testing?

Evolutions – how are SEE test needs changing?

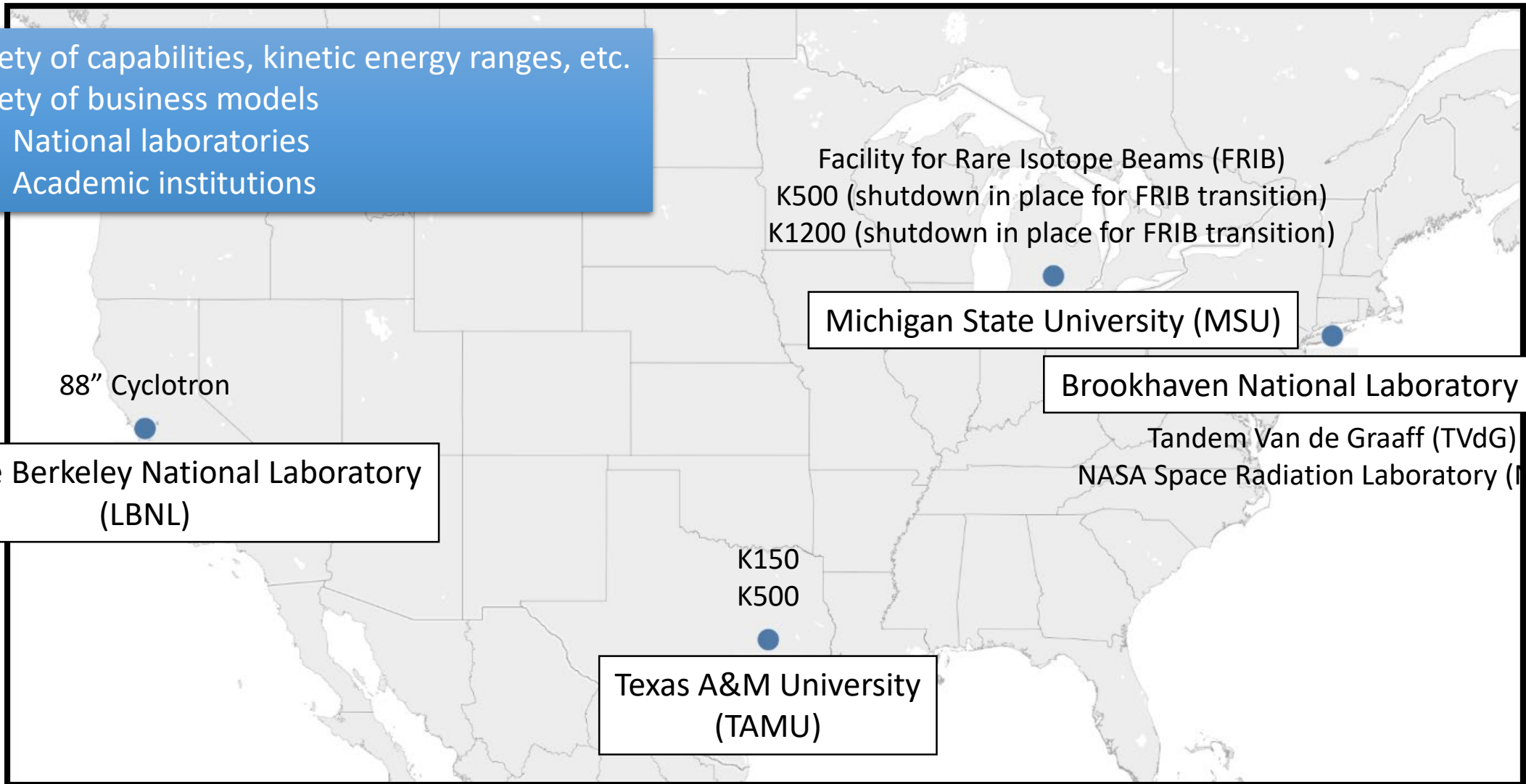
Gaps – do we have access to sufficient capacity and necessary capabilities? (requires us to project ahead many years...easier said than done)

Mitigations – what can we do to overcome challenges?

Talk will focus on heavy ion SEE testing in the United States (may generalize)
Large and diverse trade space – just one perspective
SEE test facilities are increasingly critical infrastructure for many economic sectors
...related topics could extend to proton and neutron test facilities too...

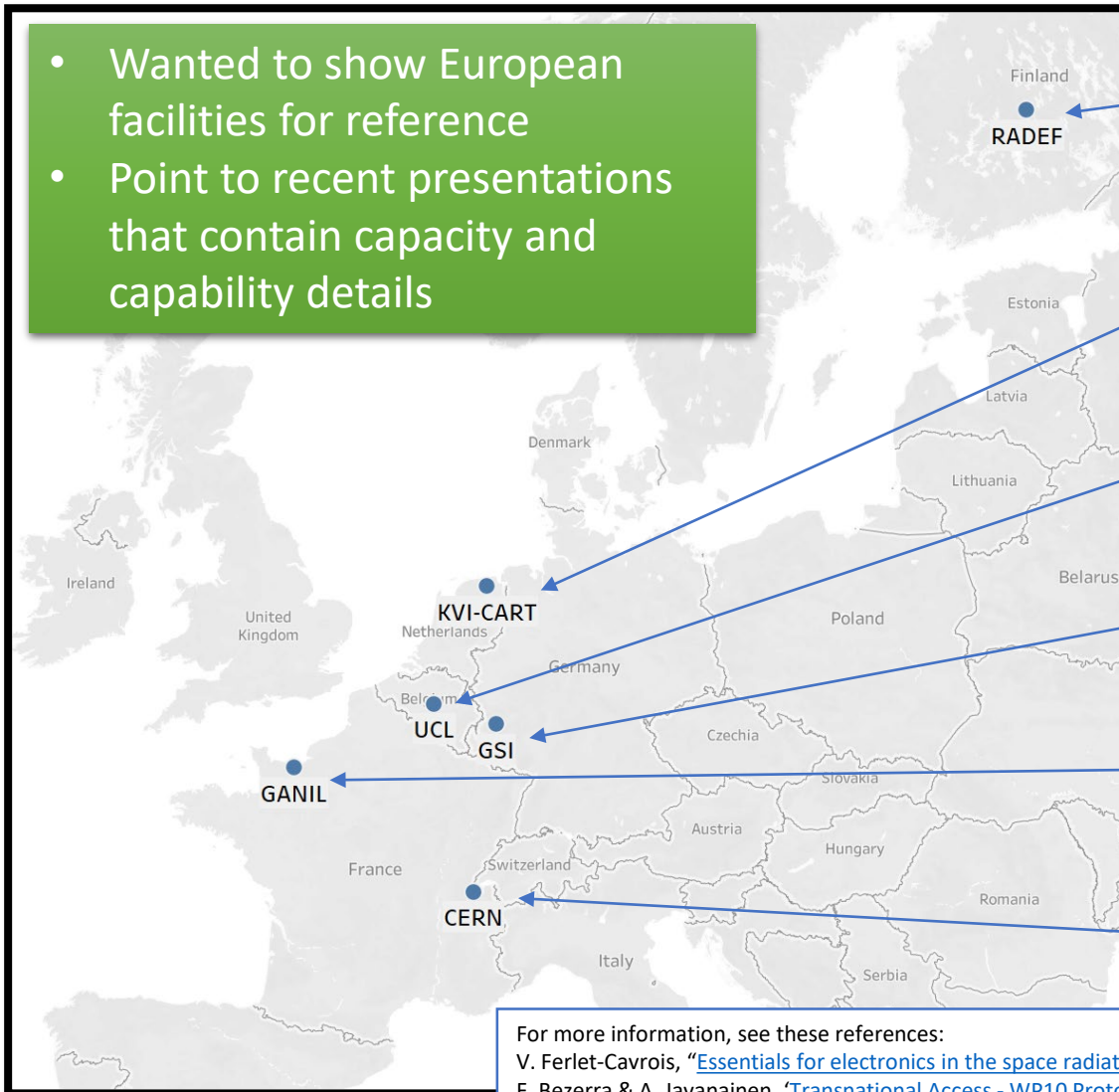
U.S. Heavy Ion Test Facilities (*currently*)

- Variety of capabilities, kinetic energy ranges, etc.
- Variety of business models
 - National laboratories
 - Academic institutions



European Heavy Ion Test Facilities (*currently*)

- Wanted to show European facilities for reference
- Point to recent presentations that contain capacity and capability details



RADIation Effects Facility (RADEF), University of Jyväskylä, Finland.

Kernfysisch Versneller Instituut (KVI) - Center for Advanced Radiation Technology (CART), University of Groningen, The Netherlands

Université Catholique de Louvain (UCL), Louvain-la-Neuve, Belgium

Gesellschaft für Schwerionenforschung (GSI), Darmstadt, Germany

Grand Accélérateur National d'Ions Lourds (GANIL), Caen, France

European Organization for Nuclear Research (CERN), Meyrin, Switzerland; Prévessin-Moëns, France

For more information, see these references:

V. Ferlet-Cavrois, "[Essentials for electronics in the space radiation environment - Test methods and facilities](#)", RADSAGA/RADNEXT, May 2021.

F. Bezerra & A. Javanainen, "[Transnational Access - WP10 Proton, heavy ion and alternative beams and irradiation](#)", RADSAGA/RADNEXT, May 2021.



ORIGINS

Why do we need SEE testing?

Breaking Down Radiation Effects

Ionizing Radiation Effects

Total Ionizing
Dose (TID)

Total Non-
Ionizing Dose
(TNID)

Single-Event Effects (SEE)

Non-
Destructive

Destructive

Primarily high-energy protons and **heavy ions**

Not including charging

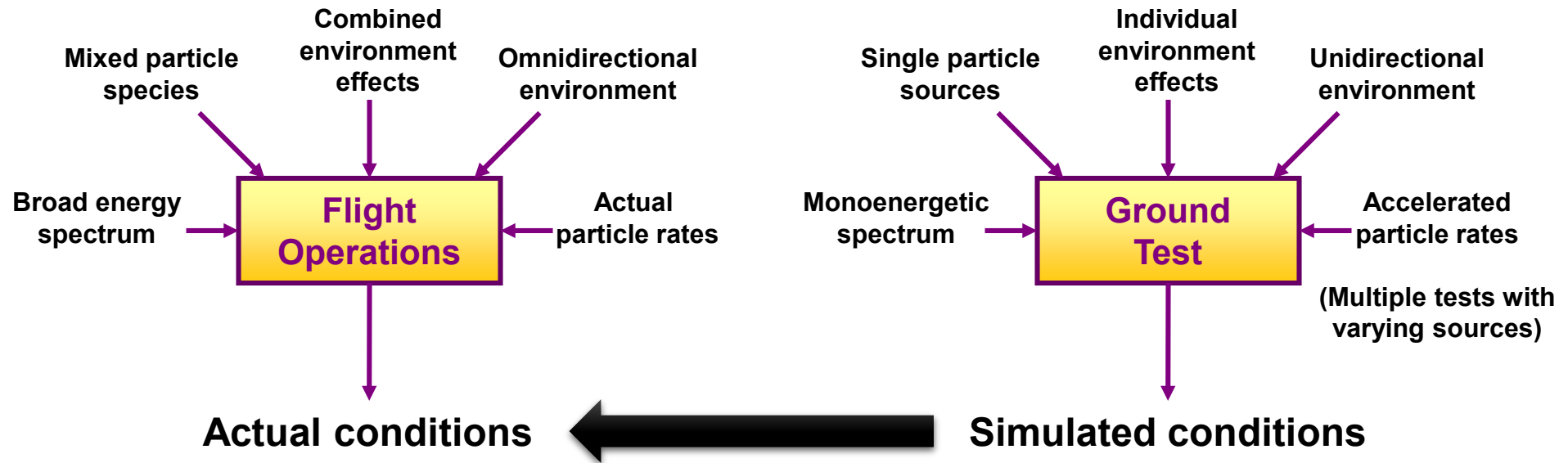
SEE Testing

- Why do testing? (two primary goals)
 1. To **determine the presence and characteristics of single events**
 - Destructive or non-destructive?
 - Voltage- and/or temperature-dependent?
 - *List goes on for a quite a while...*
 2. To **calculate bounding SEE rates as part of availability and/or reliability assessments** for a given **mission, environment, application, and lifetime (MEAL)**
 - this is what matters to designers, system engineers, etc.
- SEE testing is usually performed at **particle accelerator facilities**, which irradiate an electronic device target (or board or box) with ions

Adapted from S. Buchner, *SERESSA 2011*, Toulouse, France.

SEE Testing Fidelity

Ground ≠ space – radiation effects practitioners need to understand and account for the differences



Graphic prepared by K. A. LaBel, NASA GSFC, 2008.

*How accurate is ground-based SEE testing in predicting space-based performance?
Increasingly important considerations for new technologies*

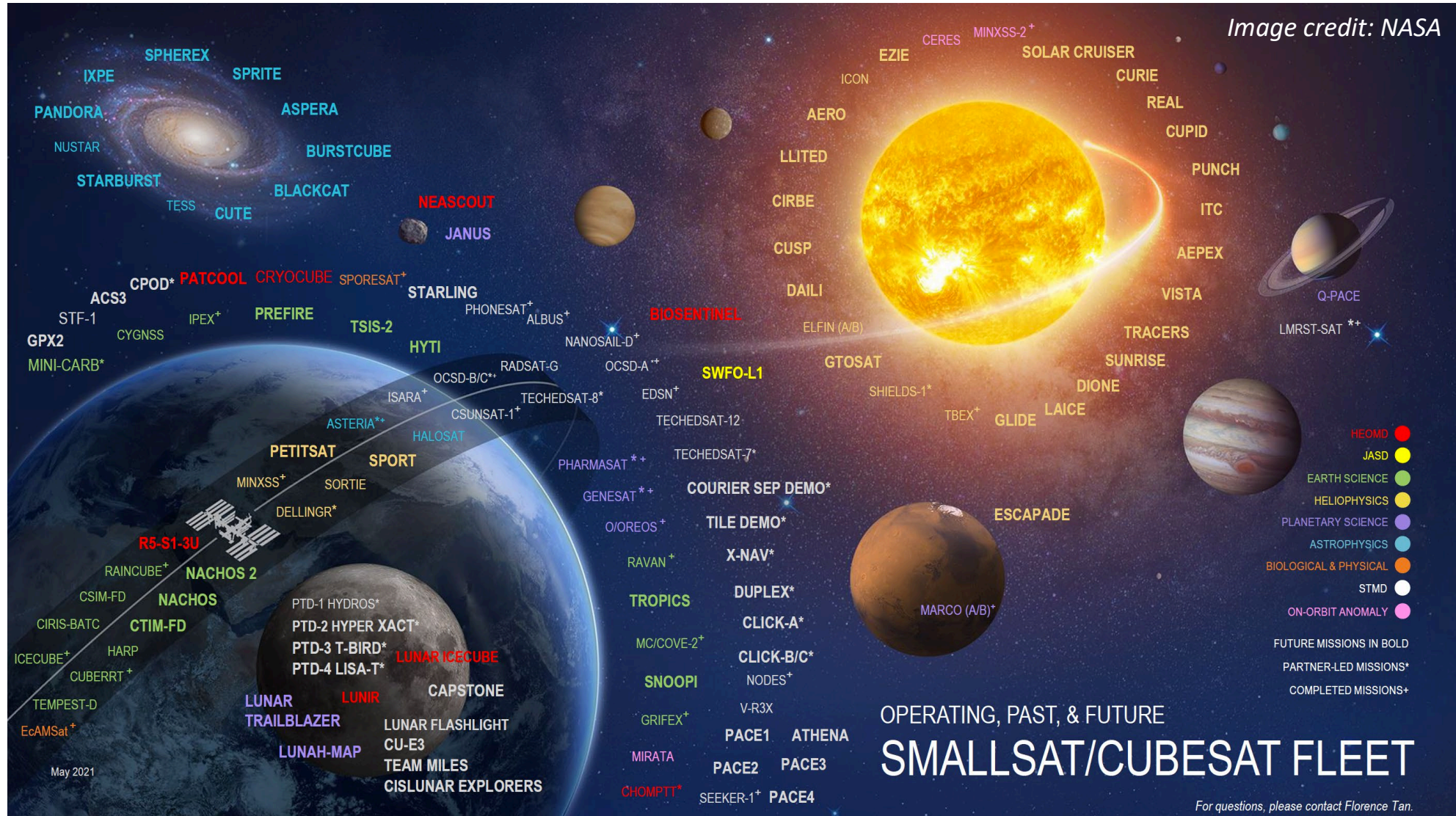


EVOLUTIONS

How are SEE test needs changing?

Program needs are growing and driving technology requirements

Space Community Growth and Diversification



[NASA SmallSat/CubeSat Fleet](#) – access link (<--> for more information on individual missions

Space Community Growth and Diversification



Human Landing System
Commercial Crew Program

Space Community Growth and Diversification



<https://www.defense.gov/>



<https://www.defense.gov/>

Defense Applications



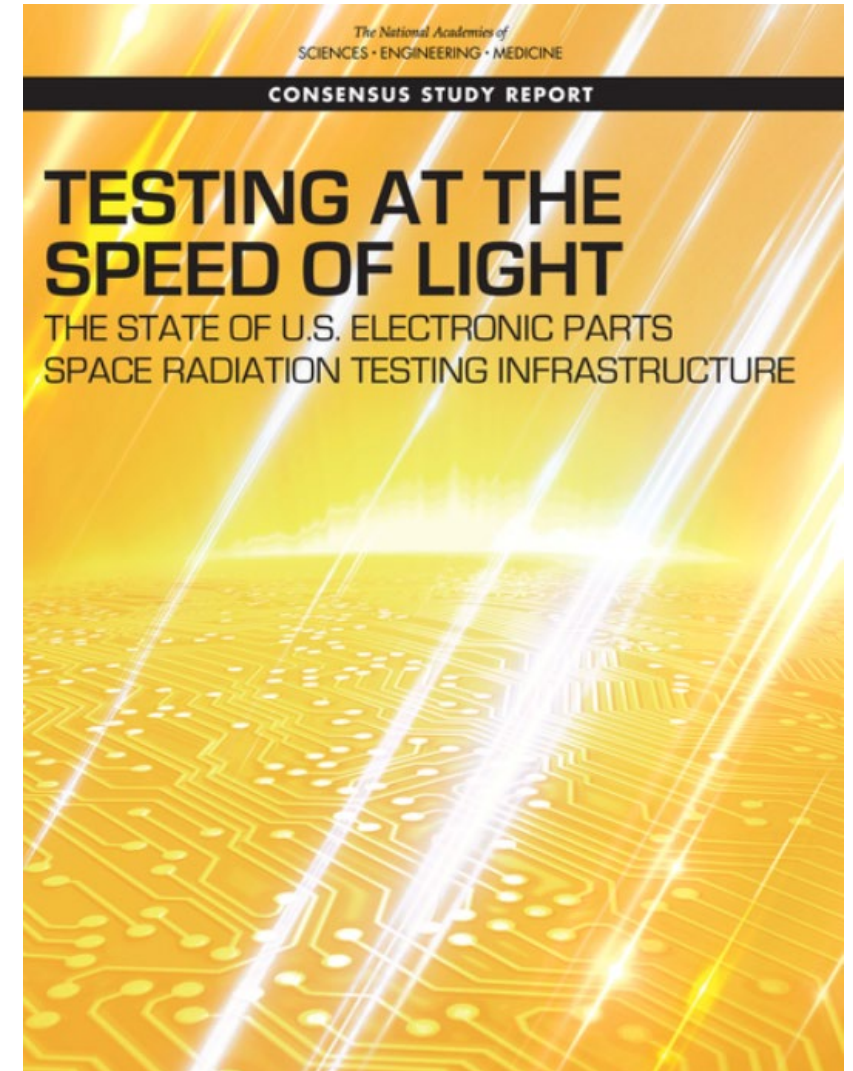
GAPS

Do we have access to sufficient capacity and necessary capabilities?

Recent Assessments (NASEM 2017-2018)

- Key findings
 - Growing use and tightening supply
 - Infrastructure showing signs of strain
 - Aging workforce in a domain that requires specialized training and skills
 - Fast-moving technology
- Points to / needs
 - More organizational coordination
 - Test facility sustainment & new investments
 - Coupled with appropriate research & development
 - Workforce development

At least one detailed assessment pre-dated this work, Aerospace Corp. TOR-2015-00473.



<https://doi.org/10.17226/24993>

Recent Assessments (AoA 2019)

- Key findings
 - Existing heavy ion SEE test facilities cannot meet current or future SEE test demand (~5000 hour/year gap)
 - Department of Defense efforts as well as U.S. Government and commercial space are driving significant increases in SEE testing demand
 - Current heavy ion accelerators for SEE testing at U.S. universities and Department of Energy labs have limited capacity and capability
 - More complex electronics (e.g., processors, ASICs, FPGAs) require more test hours
 - More advanced electronics and packaging (e.g., 3D ICs, flip-chip packages, system-on-a-chip, or system-in-a-package) require higher ion energies >100 MeV/amu

AoA Findings and Recommendations are Independent and Non-Binding



Strategic Radiation-Hardened (SRH)
Electronics Council (SRHEC)
Public Summary from Analysis of
Alternatives (AoA) for Domestic Single-
Event Effects (SEE) Test Facilities

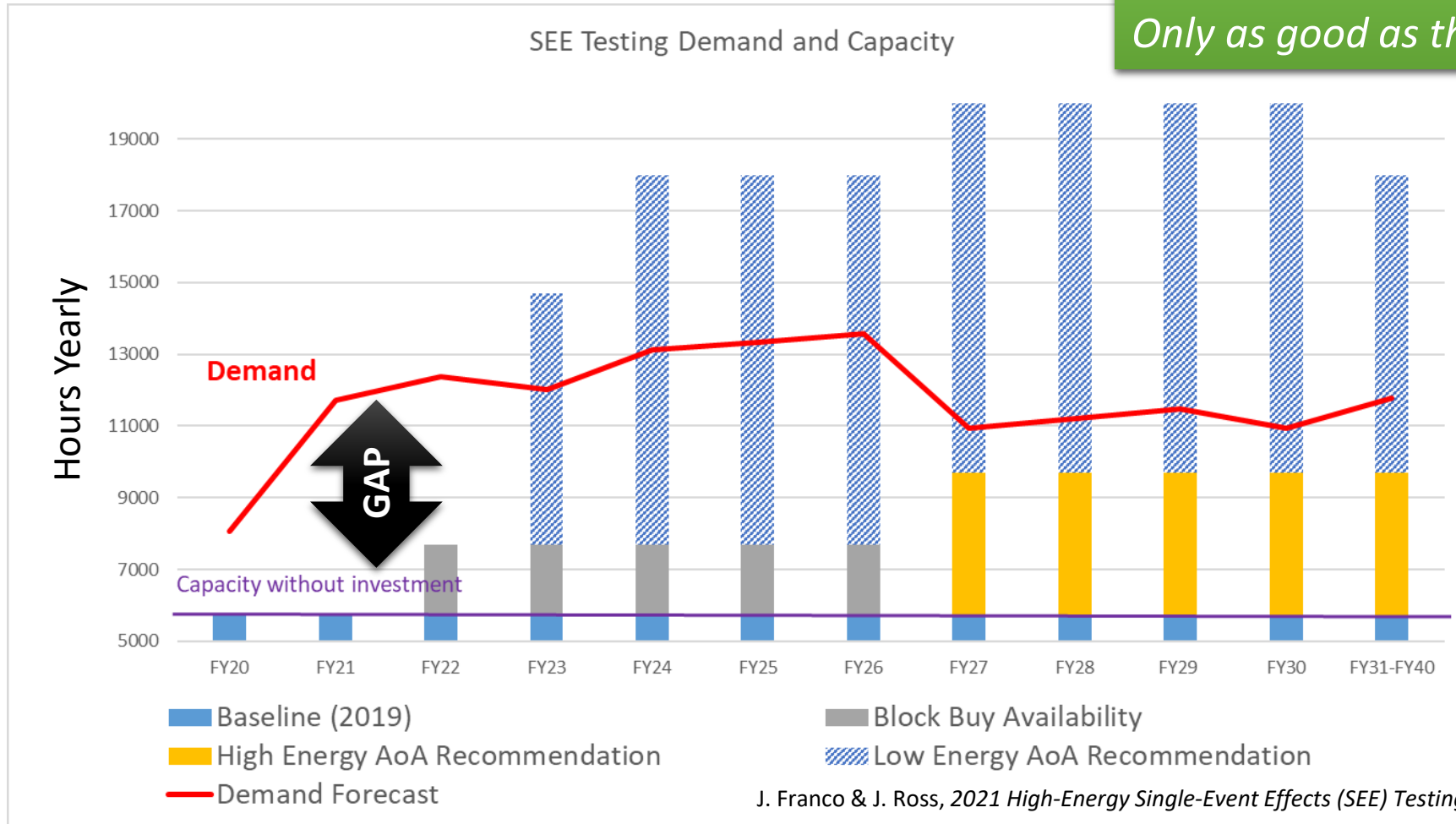
John Franco, DTRA
Jim Ross, NSWC Crane

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J. Franco & J. Ross, 2021 High-Energy Single-Event Effects (SEE) Testing Users Meeting ([slides](#))

Recent Assessments (AoA 2019)

Only a snapshot in time
Only as good as the data collected



*Demand forecast is based on Fiscal Year 2020 projections of Defense programs (other contributors too!)
 Demand input from integrators, manufacturers, and suppliers would improve fidelity of demand forecast*

Recent Assessments (AoA 2019)

- Demand for high-energy SEE testing is growing (projections only)

Low Energy SEE Test 2020

- 90% of SEE test is Low Energy
 - 10-50 MeV/n (Mega-Electron Volts /n)

2030

- 60% of SEE test is Low Energy
 - Economical test for monolithic integrated circuits
 - Issues for flip-chip, stacked die, 2.5/3D packaging, and assemblies
- Access assured with low energy investments
- TAMU K500 & K150, LBNL, FRIB Lin Seg 1, and MSU K500 meet Low Energy demand

High Energy SEE Test 2020

- 10% of SEE test is High Energy
 - >100 MeV/n

2030

- 40% of SEE test is High Energy
 - New technology and CCA level testing will demand high energy
 - Economical for new technology
- Access assured by high energy investment
- 40% is ~4000 hours/yr
 - BNL AGS or MSU K1200 meets High Energy demand

J. Franco & J. Ross, *2021 High-Energy Single-Event Effects (SEE) Testing Users Meeting* ([slides](#))



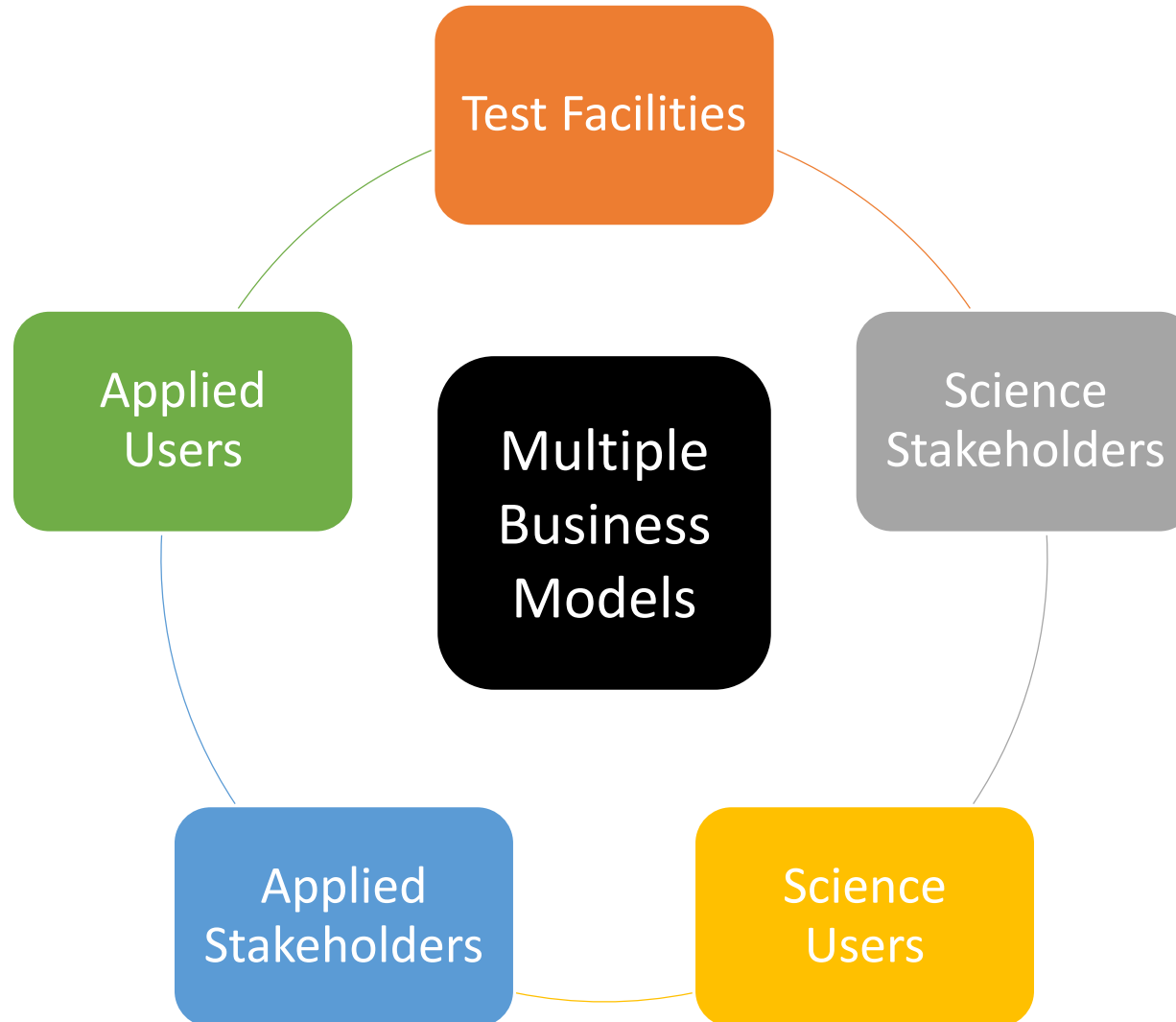
MITIGATIONS

What can we do to overcome challenges?

More Organizational Coordination

Most facilities have multiple user and stakeholder communities

SEE testers are often guests in facilities designed and built for science (e.g., nuclear physics)



Need to invest in facilities is clear, but the trade space is complex

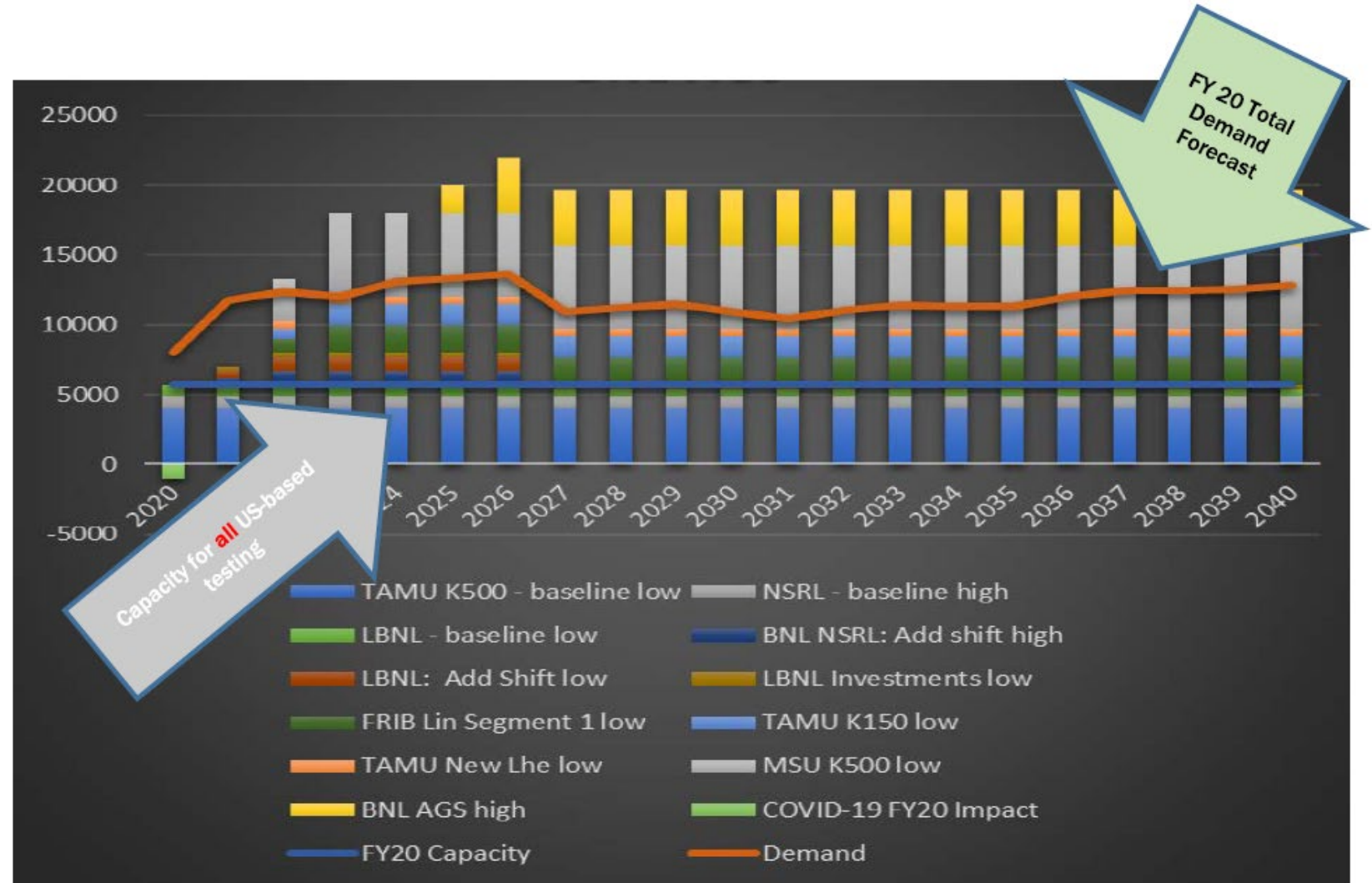
Unique time in the radiation effects community given planned investments & possibilities

Test Facility Sustainment & New Investments

- Utilize existing infrastructure to expand low-energy capacity
 - Repurpose available accelerator systems and leverage workforce, possibly gaining facilities more dedicated to SEE testing
 - Consider reliability investment for current accelerator systems to increase availability through better efficiency and less downtime
 - *Needs are immediate and investment proposals are forthcoming*
- Continue and accelerate studies for new high-energy capabilities
 - Understand demand evolution for high-energy SEE – harder to predict, but know it is coming
 - Development and utilization phasing are stretched out relative to low-energy investments
 - Requires more funding up front (vs. low-energy) and careful consideration of long-term operation and sustainment costs
 - *Needs are growing and proposals are being considered*

Capacity vs. Demand with Recommendations (AoA 2019)

- Solutions exist!
 - Range of paths to cover low- and high-energy gaps
 - Not all recommendations need to be pursued
- Investments in capacity and capabilities are evolving quickly and will play out over next several years



J. Franco & J. Ross, 2021 High-Energy Single-Event Effects (SEE) Testing Users Meeting ([slides](#))

Summary

- Heavy ion SEE testing is essential for robust space exploration, science, and technology capabilities
 - Essential part of the space industrial base
- Growing space economy and expanding mission objectives are driving demand and have created gaps in both capacity and capabilities
- Capacity and capability shortfall mitigations exist and require both sustained funding and coordination to execute successfully
- *Higher fidelity demand data, updated regularly, would help support investment and sustainment options (new way of thinking for radiation effects community)*
- *Same thoughts might be applicable to other types of SEE testing infrastructure*
- *While specifics may differ, general themes appear outside the U.S. too*

The background of the slide is a composite of two cosmic images. The top half features a dark blue and black space scene with a prominent blue nebula on the right and several bright, multi-pointed stars. The bottom half shows a similar scene but with a warm, golden-yellow and green color palette, suggesting a different nebula or star formation region. The text is centered in a white horizontal band.

THANK YOU FOR YOUR ATTENTION

Acronyms

| Abbreviation | Definition |
|--------------|--|
| 3D | 3-dimensional |
| AGS | Alternating Gradient Synchrotron |
| AoA | Analysis of Alternatives |
| ASIC | Application-Specific Integrated Circuit |
| BNL | Brookhaven National Laboratory |
| CART | Center for Advanced Radiation Technology |
| CCA | Circuit Card Assembly |
| CERN | European Organization for Nuclear Research |
| COVID | Coronavirus Disease |
| ETW | Electronics Technology Workshop |
| FPGA | Field Programmable Gate Array |
| FRIB | Facility for Rare Isotope Beams |
| FY | Fiscal Year |
| GANIL | Grand Accélérateur National d'Ions Lourds |
| GSFC | Goddard Space Flight Center |
| GSI | Gesellschaft für Schwerionenforschung |
| IC | Integrated Circuit |
| KVI | Kernfysisch Versneller Instituut |

| Abbreviation | Definition |
|--------------|---|
| LBNL | Lawrence Berkeley National Laboratory |
| MEAL | Mission, Environment, Application, and Lifetime |
| MSU | Michigan State University |
| NASA | National Aeronautics and Space Administration |
| NASEM | National Academies of Sciences, Engineering, and Medicine |
| NEPP | NASA Electronic Parts and Packaging (Program) |
| NSRL | NASA Space Radiation Laboratory |
| RADEF | RADIation Effects Facility |
| SEE | Single-Event Effects |
| SEE | Single-Event Effects |
| SRH | Strategic Radiation-Hardened |
| SRHEC | Strategic Radiation-Hardened Electronics Council |
| TAMU | Texas A&M University |
| TID | Total Ionizing Dose |
| TNID | Total Non-Ionizing Dose |
| TVdG | Tandem Van de Graaff |
| U.S. | United States |
| UCL | Université Catholique de Louvain |